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/JK/		Kojima, I. "EDA Aiming at Verification, Rapid Response to System LSI" Nikkei Electronics, Nikkei Business Publication Inc., August 10, 1998, No 723, pp. 99-109.							
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EXAMINER /Jung Kim/					DATE CONSIDERED 06/21/2007				
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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INITIALS	. CITE	Country Codes -Number 4 -JGnd Codes (/f known)		MM-DD-YYYY	Applicant of Cited Document	Figu		Yea	No	
/JK/			JP 05-128197	05/25/1995	Messharu		1	X		
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/JK/		pp 77	Narits of al, "Board Level Simulation with R4400 Model," Study Report in Information Processing Society of Japan, Dec 1995, pp 77-84, Vol 95, No 119(DA-78)							
/JK/		Takayama et al, "A High Speed Logic Verification System of Large Scale Digital Designs," Research Report of Information Processing Society of Japan, Jan 1995, pp 9-16, Vol 95, No 6(DA-73)								
/JK/	Notice of Reasons for Rejection Issued by Japanese Patent Office (Translation) 2006									
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